

Multi-Transverse-Mode Optical Processors: Towards On-chip Programming and Calibration

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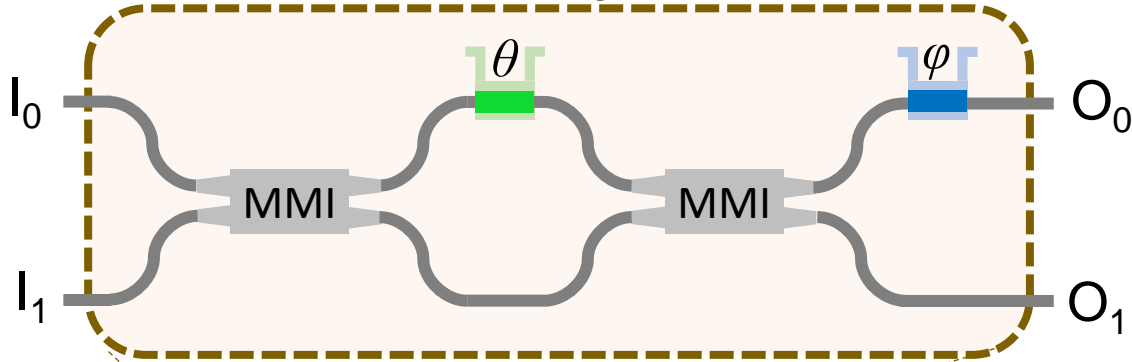
May 2022

Presentation Outline

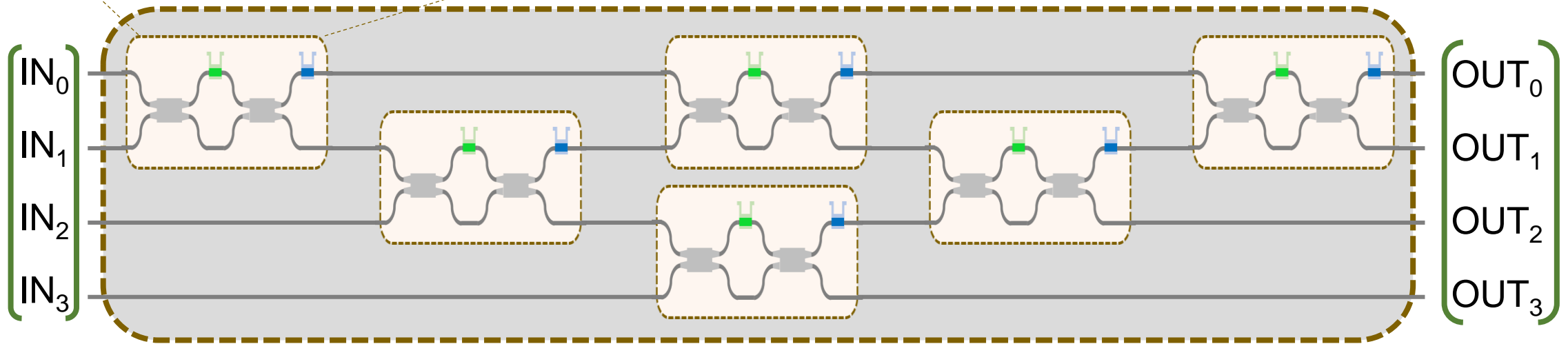
- ❖ Review on programmable optical processors
- ❖ Challenges in calibration and programming of conventional optical processors
- ❖ Proposing Multi-transverse-mode optical processor (MTMOP) to address the calibration issues
- ❖ Experimental validation of MTMOP
- ❖ Conclusion

Programmable optical processors – building block

2 × 2 Building Block

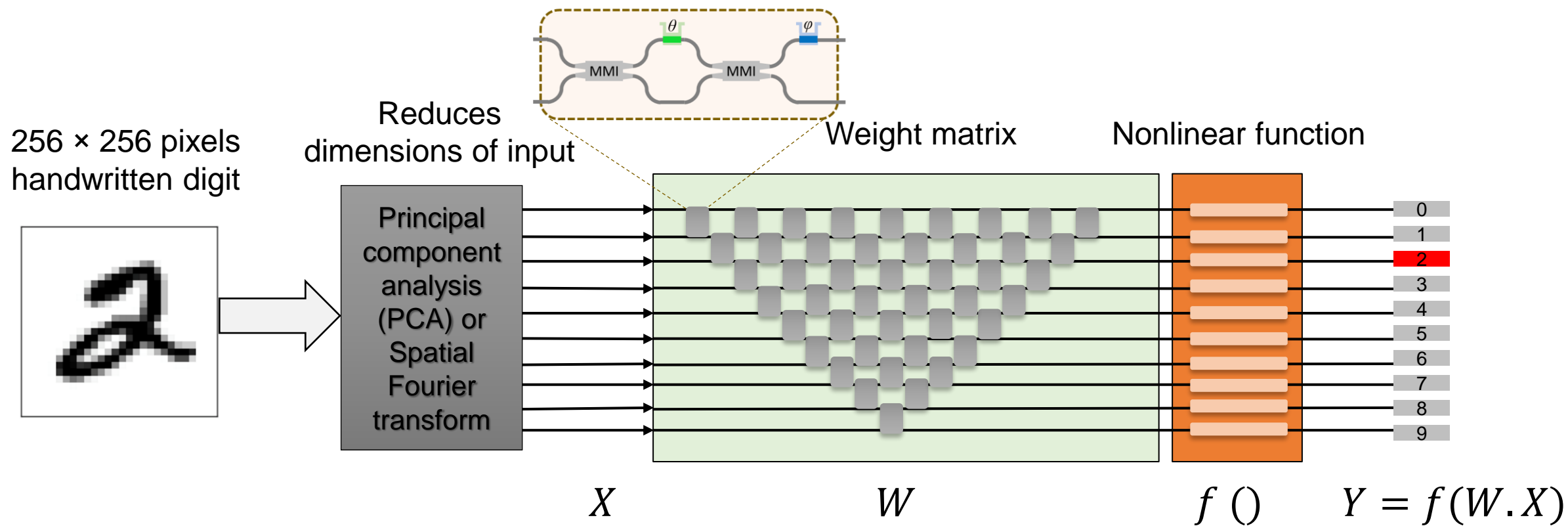


$$\begin{bmatrix} E_{O_1} \\ E_{O_2} \end{bmatrix} = j e^{j(\theta/2)} \begin{bmatrix} e^{j\phi} \sin(\theta/2) & e^{j\phi} \cos(\theta/2) \\ \cos(\theta/2) & -\sin(\theta/2) \end{bmatrix} \begin{bmatrix} E_{I_1} \\ E_{I_2} \end{bmatrix}$$



Programmable Optical Processor

Programmable optical processors for ML

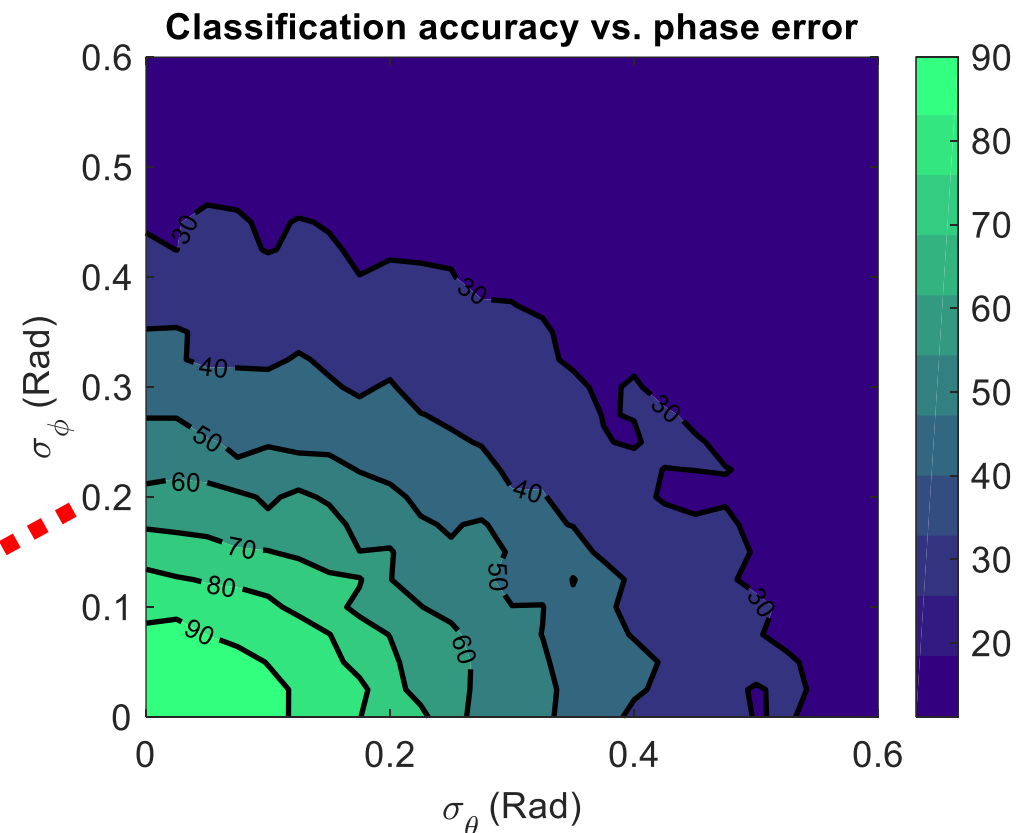


Phase error, calibration, and programming

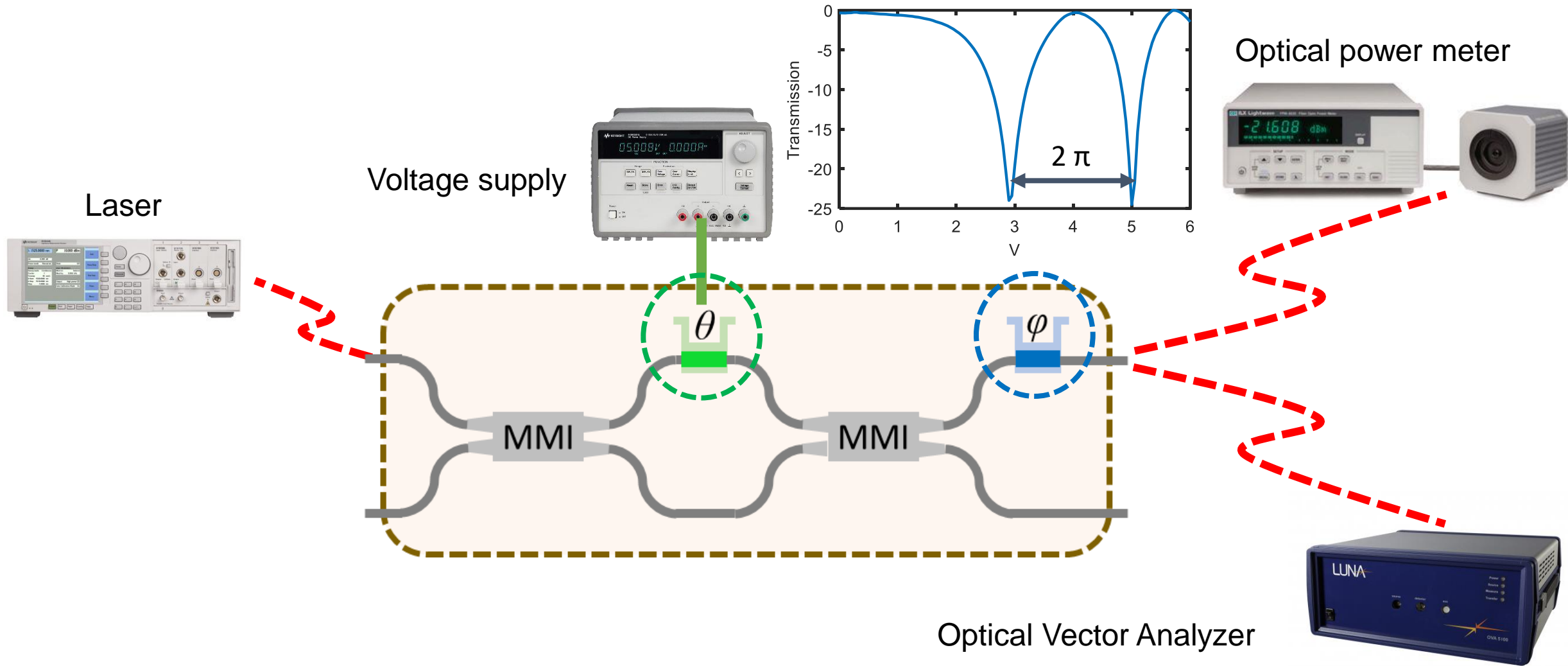
How precise should the phase setting be?

- ❑ Phase shifter inaccuracy caused by various effects, mainly thermal crosstalk and electro-optic precision (bias voltage accuracy and stability)
- ❑ Accuracy drops from 90% down to 60 for phase variance of less than 0.1 rad to approximately 0.2 rad.
- ❑ A 100 um TiN-based TOPS with a 2.7K temperature fluctuation lead to an accuracy drop to 60%
- ❑ This is equivalent to approximately 30 mV of voltage deviation

2.7 K of temperature error
or 30 mV voltage deviation



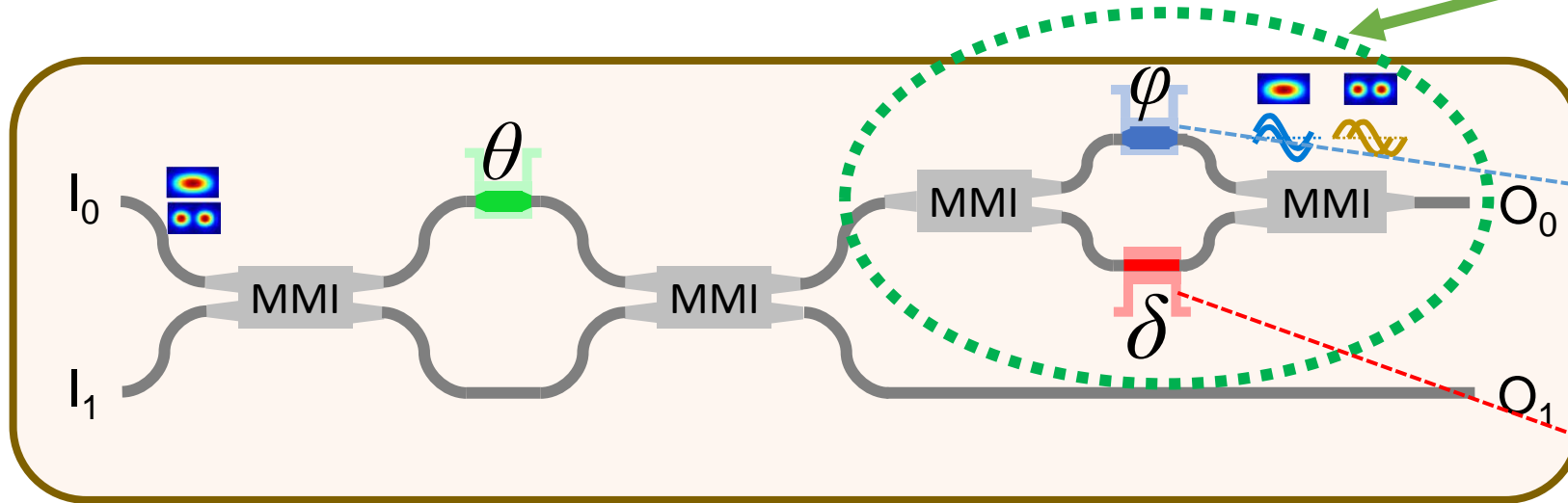
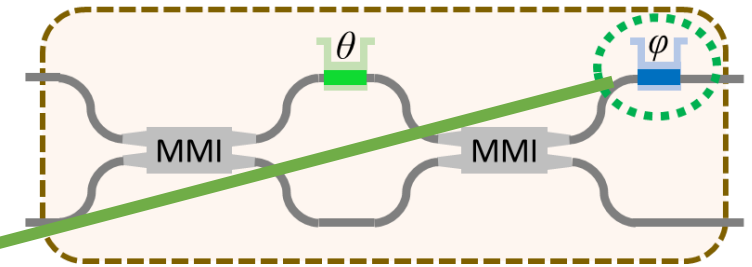
Calibration and programming: optical phase measurement



Proposed approach: Monitoring phase shift using MTMOP

- ❖ Using two transverse electric (TE) modes
- ❖ TE0 carries the main signal
- ❖ TE1 for calibration and programming purposes
- ❖ MTMOP building block converts TE0 phase shift into TE1 power

Conventional 2x2 Building Block



Multi-transverse mode optical processor (MTMOP) 2x2 Building Block

Mode insensitive phase shifter

$$\frac{dn_{eff}(TE0)}{dT} = \frac{dn_{eff}(TE1)}{dT}$$

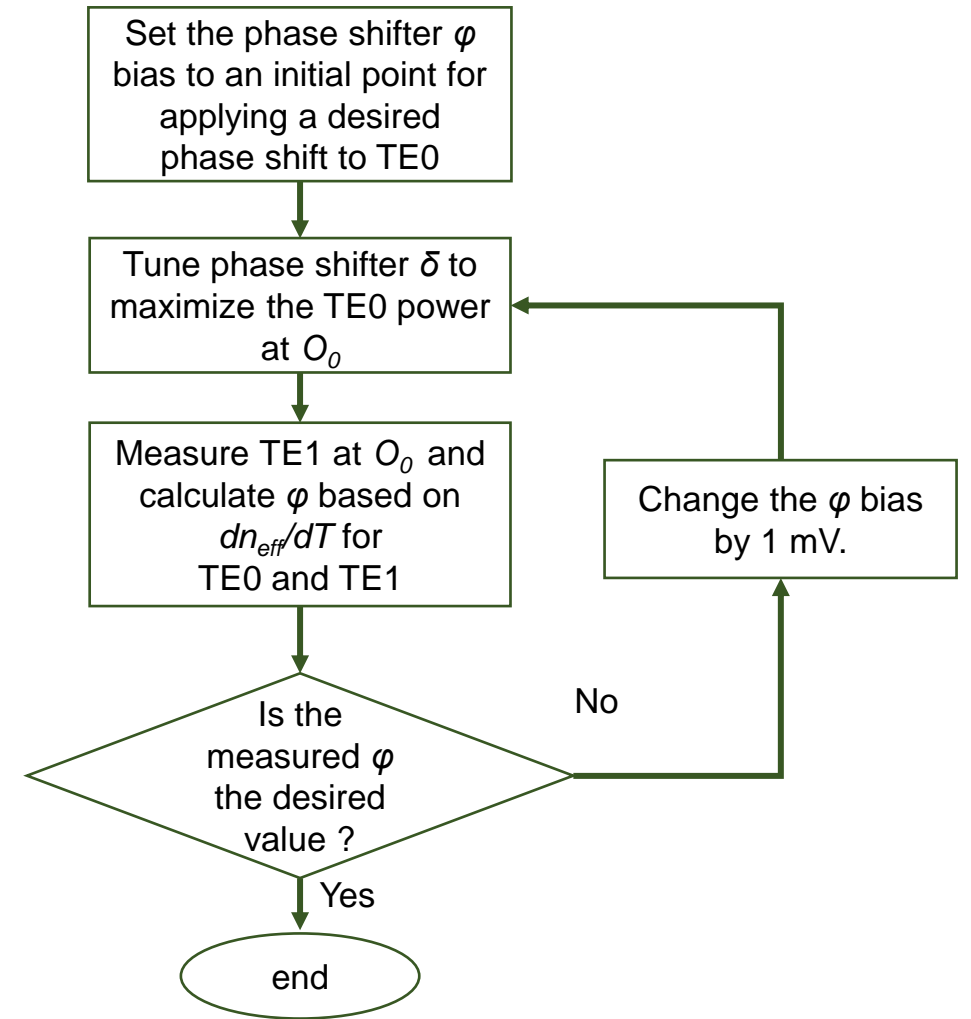
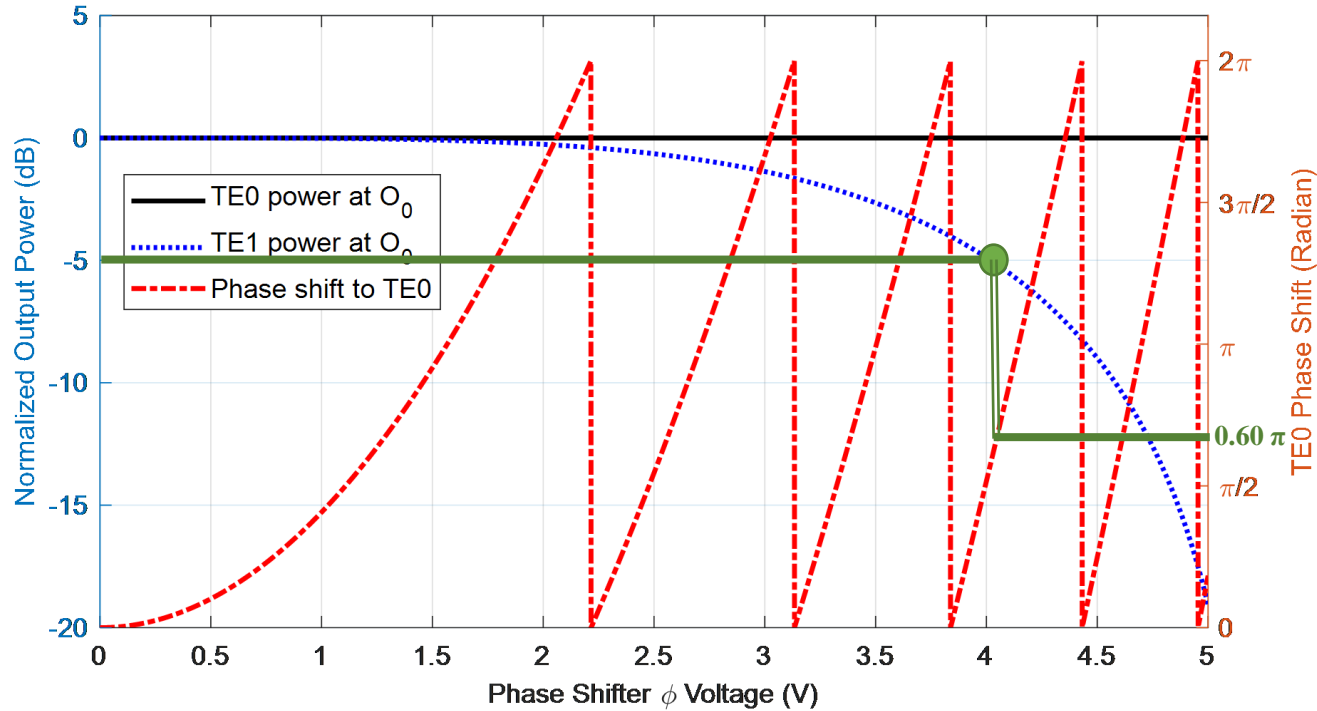
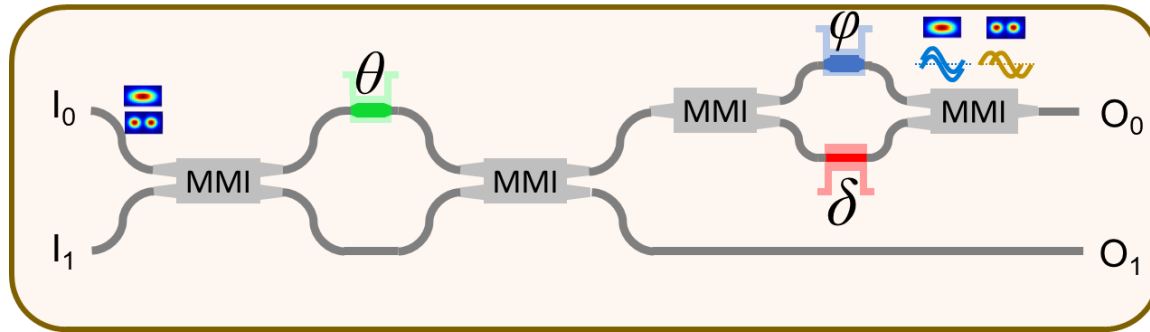
Width= 4 μm

Mode sensitive phase shifter

$$\frac{dn_{eff}(TE0)}{dT} \neq \frac{dn_{eff}(TE1)}{dT}$$

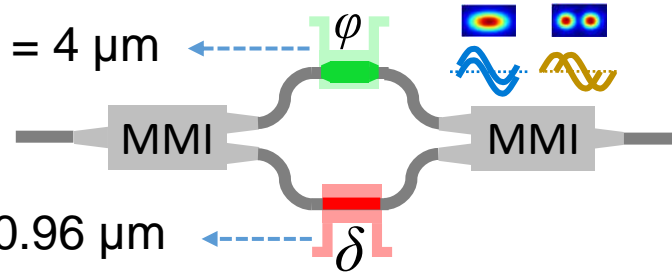
Width= 0.96 μm

MTMOP principles of operation

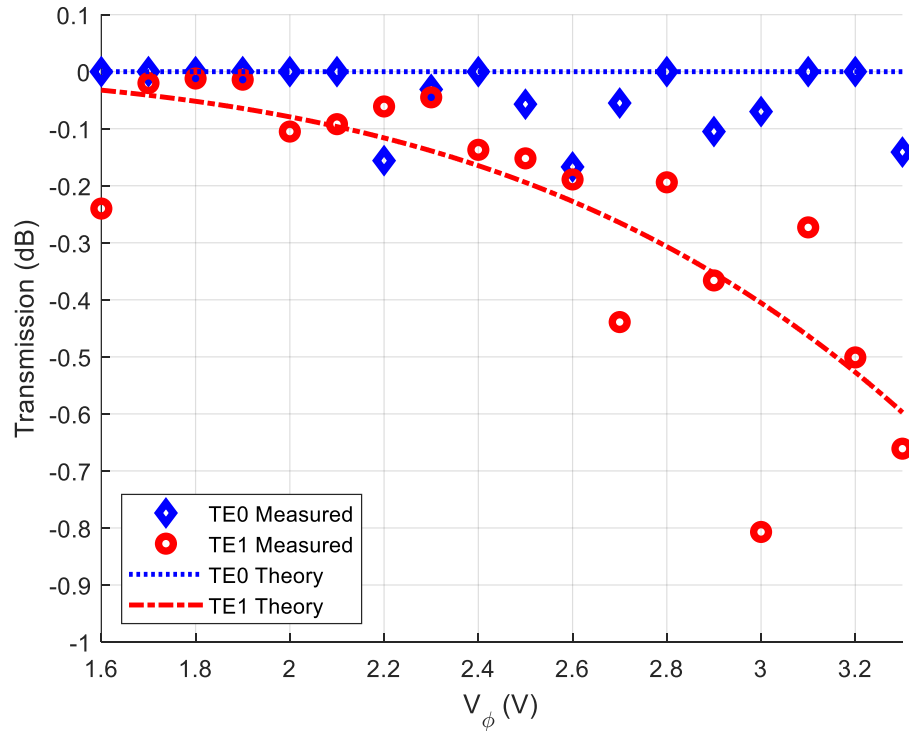


Experimental validation – Preliminary results

Mode insensitive - width = 4 μm



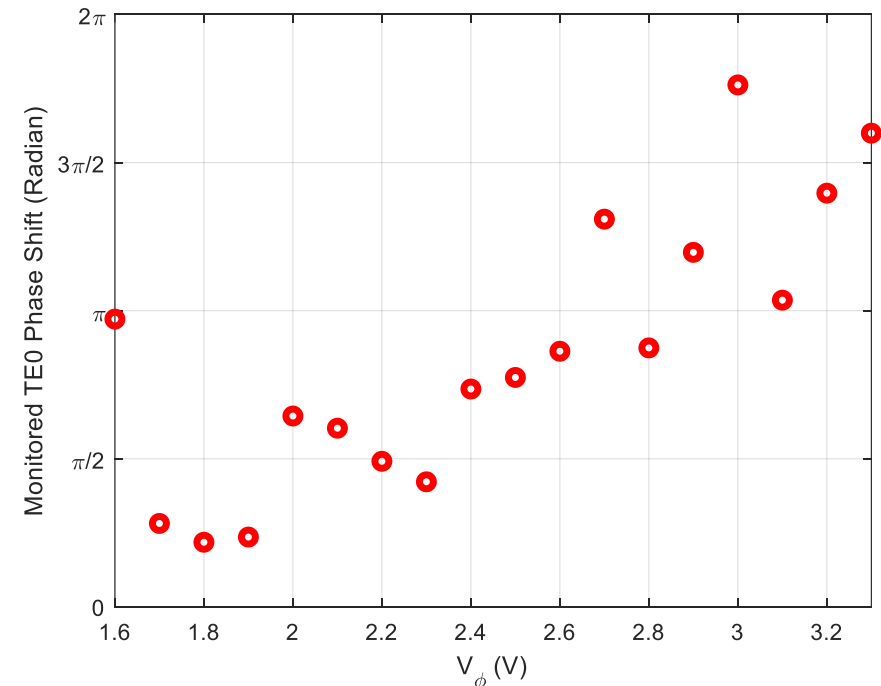
Mode sensitive - width = 0.96 μm



Transmission TE0 and TE1 modes

Thermo-optic coefficient, $d n_{\text{eff}}/dT$

	TE0	TE1
ϕ	1.74	1.74
δ	1.80	1.96



Extracted TE0 phase shift from measured TE1 transmission

Conclusion and future work

Conclusion

- ❖ Proposing the MTMOP: A Multi-Transverse-Mode Optical Processor
- ❖ The MTMOP design addresses calibration challenges of optical processors.
- ❖ The MTMOP enables an embedded calibration and programming of the optical processor
- ❖ Experimentally validated an MTMOP prototype on SiPh.

Future work

- ❖ Increase the mode sensitivity of mode-sensitive phase shifter.

Slides are available at: <http://rahbardar.research.mcgill.ca/>

More information on MTMOP:

Kaveh Mojaver and Odile Liboiron-Ladouceur, “On-chip Optical Phase Monitoring in Multi-Transverse-Mode Integrated Silicon-based Optical Processors,” arXiv:2205.10414v1, May 2022

Thank you!

the
Photonic DataCom
team

